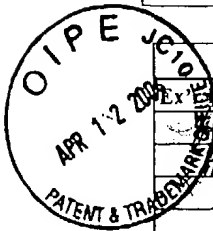


<b>INFORMATION DISCLOSURE STATEMENT</b>	Docket: P0419	Ser. No. 09/945,244
	Applicant: Sharma et al.	
	Filed: August 31, 2001	Group: 2621



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Examiner Signature:

Abdullah Tohbatker

Date Considered:

11/20/04

\*Examiner: Initial if considered, whether or not in conformance with MPEP 609; draw line through cite if not in conformance and not considered. Include copy of this form with next communication to applicant.